

**Search Notes**

Application/Control No.

10/796,194

Examiner

Ren L. Yan

Applicant(s)/Patent under  
Reexamination

SATOH ET AL.

Art Unit

2854

**SEARCHED**

Class	Subclass	Date	Examiner
101	116		
	117		
	118		
	232		
271	10.01		
	10.03		
	110		
	111		
	258.01		
	259		
	265.01		
	265.02		
above search 3/22/07 RY updated			

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner
101	118	7/26/07	RY
	232		
271	110		
	265.02		

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR